

IN THE CLAIMS

Please amend Claims 1, 5, 6, 13, 14, 17 and 18 to read as follows.

1. (Currently Amended) A ferroelectric thin film element comprising a substrate and an epitaxial ferroelectric thin film that has a plurality of crystal faces and that is provided on said ~~substrate~~: substrate,

wherein said epitaxial ferroelectric thin film satisfies a relation $z/z_0 > 1.003$, wherein a crystal face parallel to a crystal face of a surface of ~~the said~~ substrate, among the crystal faces of said epitaxial ferroelectric thin film, is taken as a Z crystal face, a face spacing of ~~said the~~ Z crystal face is taken as z and a ~~space-face spacing~~ of the Z crystal face of a material constituting said epitaxial ferroelectric thin film in a bulk state is taken as z_0 , and

wherein said epitaxial ferroelectric thin film also satisfies a relation $0.997 \leq x/x_0 \leq 1.003$, wherein one of the crystal faces of said epitaxial ferroelectric thin film perpendicular to the Z crystal face is taken as an X crystal face, a face spacing of the X crystal face is taken as x and a face spacing of the X crystal face of the material constituting said epitaxial ferroelectric thin film in a bulk state is taken as x_0 .

2. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film has a thickness within a range of 2 to 100 nm.

3. (Original) A ferroelectric thin film element according to claim 1, further comprising at least a buffer layer between said substrate and said epitaxial ferroelectric thin film.

4. (Original) A ferroelectric thin film element according to claim 3, wherein at least one of said substrate and said buffer layer is electroconductive.

5. (Currently Amended) A ferroelectric thin film element according to claim 1, wherein ~~said epitaxial ferroelectric thin film~~ has a crystal orientation degree of the Z crystal face of said epitaxial ferroelectric thin film, measured by a $2\theta/\theta$ method with an X-ray incident angle θ to the Z crystal face, is 90 % or higher.

6. (Currently Amended) A ferroelectric thin film element according to claim 1, wherein ~~said the~~ Z crystal face has a crystal orientation degree of 99 % or higher.

7. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film has a perovskite structure.

8. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film includes a lead (Pb) atom or an oxygen (O) atom as a constituent atom.

9. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film has a tetragonal crystal structure and the Z crystal face is a (001) face.

10. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film has a rhombohedral crystal structure and the Z crystal face is a (111) face.

11. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film has a hexagonal crystal structure and the Z crystal face is a (0001) face.

12. (Original) A ferroelectric thin film element according to claim 1, wherein said epitaxial ferroelectric thin film has a rhombic crystal structure and the Z crystal face is a (011) face.

13. (Currently Amended) A piezoelectric actuator comprising a substrate and an epitaxial ferroelectric film that has a plurality of crystal faces and that is provided on said ~~substrate: substrate,~~

wherein said epitaxial ferroelectric film satisfies a relation $z/z_0 > 1.003$, wherein a crystal face parallel to a crystal face of a surface of ~~the said~~ the substrate, among the crystal faces of said epitaxial ferroelectric film, is taken as a Z crystal face, a face spacing of ~~said the~~ the Z crystal face is taken as z and a ~~space~~ face spacing of the Z crystal face of a material constituting said epitaxial ferroelectric film in a bulk state is taken as z_0 , and

wherein said epitaxial ferroelectric film also satisfies a relation $0.997 \leq x/x_0 \leq 1.003$, wherein one of the crystal faces of said epitaxial ferroelectric film perpendicular to the Z crystal face is taken as an X crystal face, a face spacing of the X crystal face is taken as x and a face spacing of the X crystal face of the material constituting said epitaxial ferroelectric film in a bulk state is taken as x_0 .

14. (Currently Amended) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric ~~thin~~-film has a thickness within a range of 100 nm to 10 μm .

15. (Original) A piezoelectric actuator according to claim 13, further comprising at least a buffer layer between said substrate and said epitaxial ferroelectric film.

16. (Original) A piezoelectric actuator according to claim 15, wherein at least one of said substrate and said buffer layer is electroconductive.

17. (Currently Amended) A piezoelectric actuator according to claim 13, wherein ~~said epitaxial ferroelectric film has~~ a crystal orientation degree of the Z crystal face of said epitaxial ferroelectric film, measured by a $2\theta/\theta$ method with an X-ray incident angle θ to the Z crystal face, is 90 % or higher.

18. (Currently Amended) A piezoelectric actuator according to claim 13, wherein ~~said the~~ Z crystal face has a crystal orientation degree of 99 % or higher.

19. (Original) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric film has a perovskite structure.

20. (Original) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric film includes a lead (Pb) atom or an oxygen (O) atom as a constituent atom.

21. (Original) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric film has a tetragonal crystal structure and the Z crystal face is a (001) face.

22. (Original) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric film has a rhombohedral crystal structure and the Z crystal face is a (111) face.

23. (Original) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric film has a hexagonal crystal structure and the Z crystal face is a (0001) face.

24. (Original) A piezoelectric actuator according to claim 13, wherein said epitaxial ferroelectric film has a rhombic crystal structure and the Z crystal face is a (011) face.

25. (Original) A liquid discharge head for discharging a liquid utilizing a piezoelectric actuator according to claim 13.